Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,774	YUN ET AL.	
Examiner	Art Unit	_
Pita P. Patol	1746	

	CEAD	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
68	3, 12.26	4/14/2006	RRP

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC		')
	DATE	EXMR
Inventor search.	4/14/2006	RRP
EAST key word search.	4/14/2006	RRP
Refreshed class/ subclass search.	8 5 06	RRP
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